

Semiconductor Device Processing

(반도체 소자 공정 및 실습)

Lecture 1. Introduction

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Semiconductor Device Processing

Wikipedia

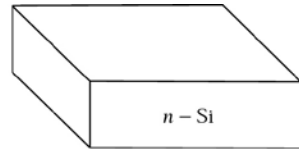
Semiconductor device fabrication is the process used to create the [integrated circuits](#) that are present in everyday [electrical](#) and [electronic](#) devices. It is a multiple-step sequence of photo lithographic and chemical processing steps during which electronic circuits are gradually created on a [wafer](#) made of pure [semiconducting](#) material. [Silicon](#) is almost always used, but various [compound semiconductors](#) are used for specialized applications. The entire manufacturing process, from start to packaged chips ready for shipment, takes six to eight weeks and is performed in highly specialized facilities referred to as [fabs](#).



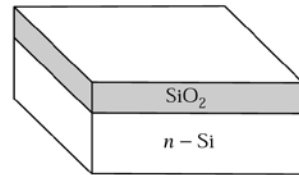
Prerequisites – Semiconductor Physics and Devices

Textbook : Fundamentals of Semiconductor Fabrication (May, Sze)

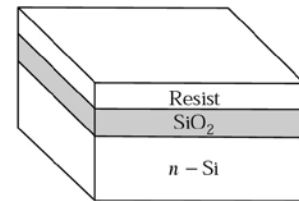
Fabrication of a silicon PN diode



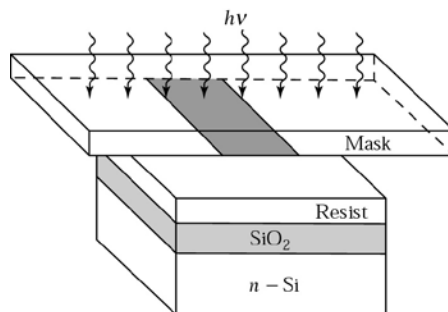
(a)



(b)



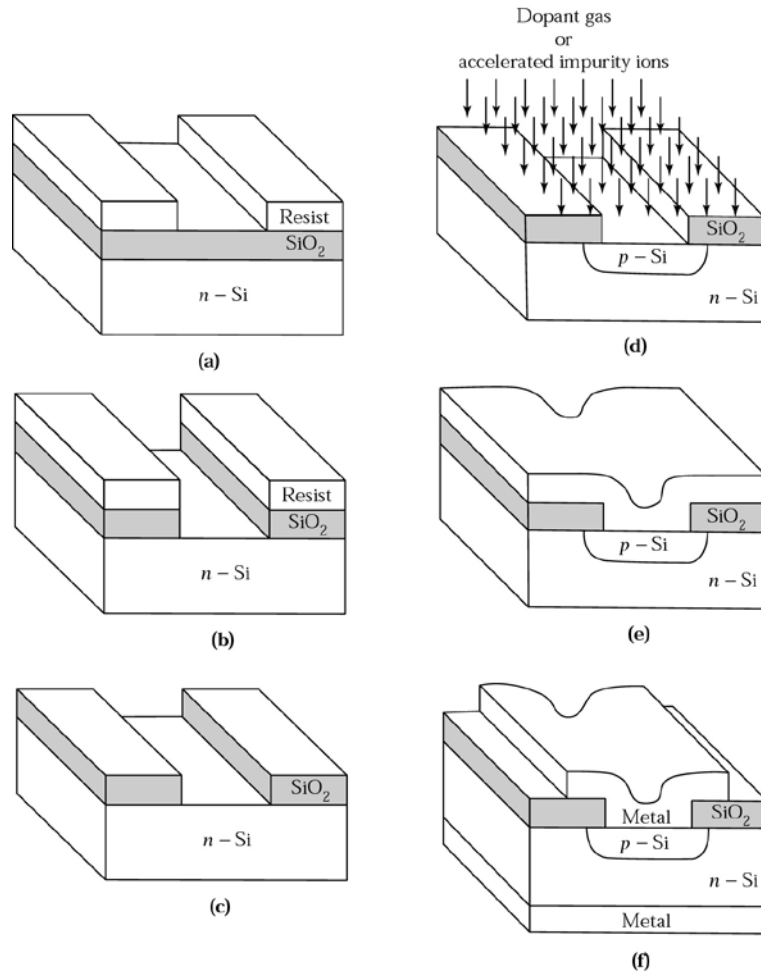
(c)



(d)

- (a) A bare *n*-type Si wafer.
- (b) An oxidized Si wafer by dry or wet oxidation.
- (c) Application of resist.
- (d) Resist exposure through the mask.

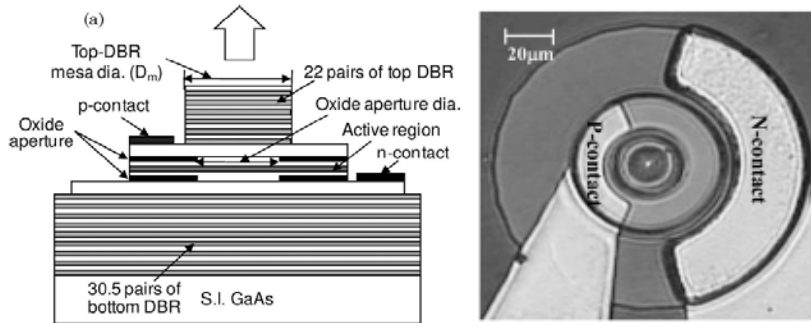
Fabrication of a silicon PN diode



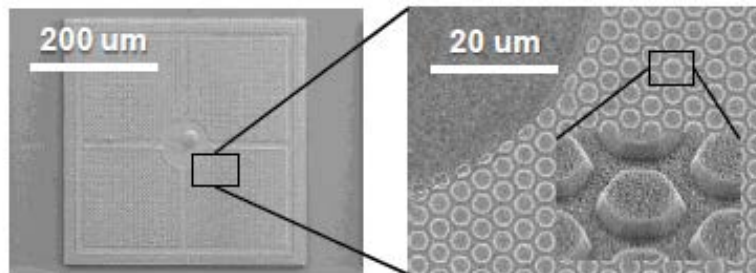
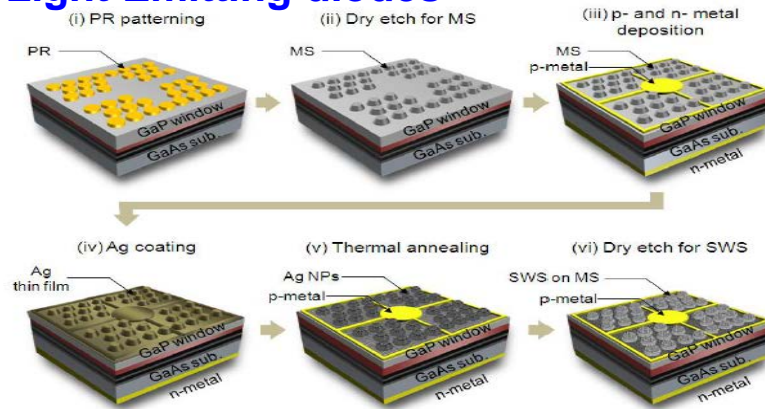
(a) The wafer after the development. (b) The wafer after SiO_2 removal. (c) The final result after a complete lithographic process. (d) A p - n junction is formed in the diffusion or implantation process. (e) The wafer after metallization. (f) A p - n junction after the complete processes.

Examples of semiconductor devices/structures

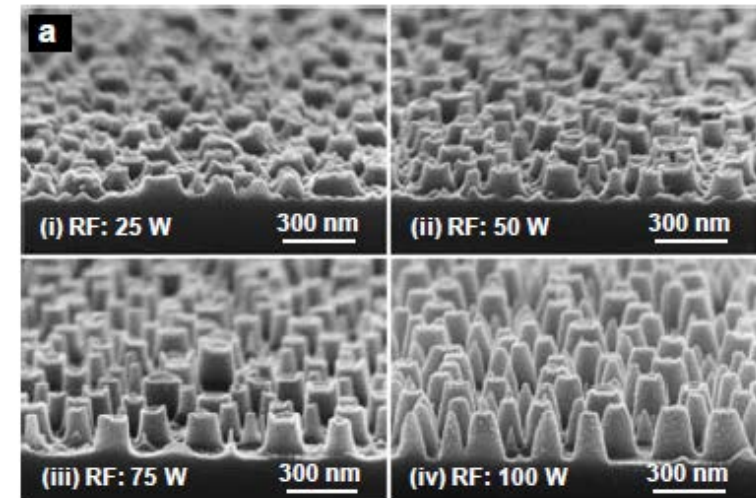
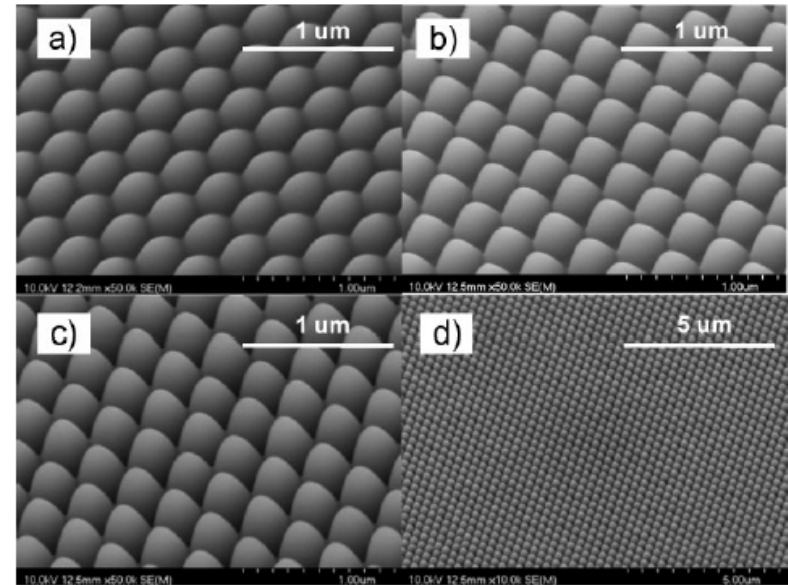
Laser diodes



Light Emitting diodes

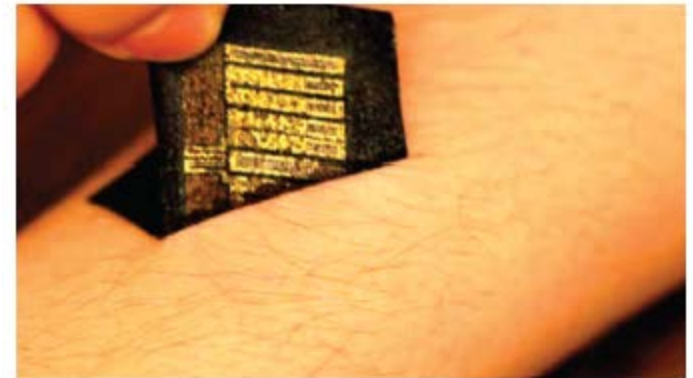
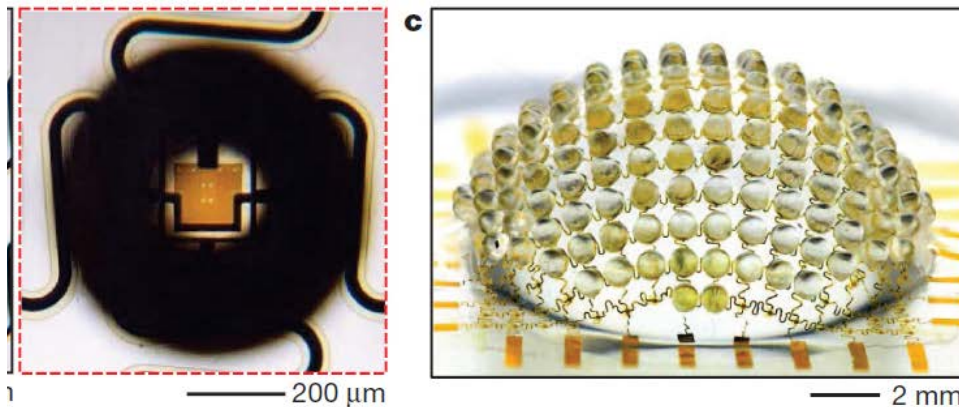
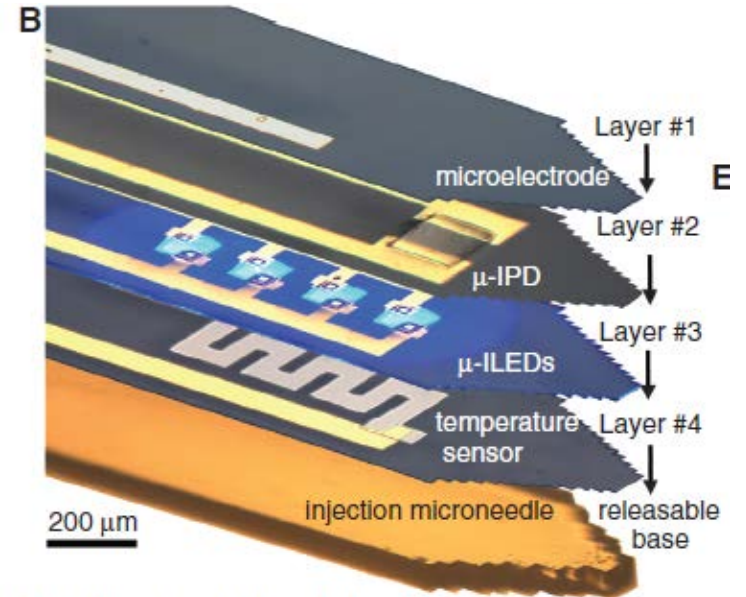
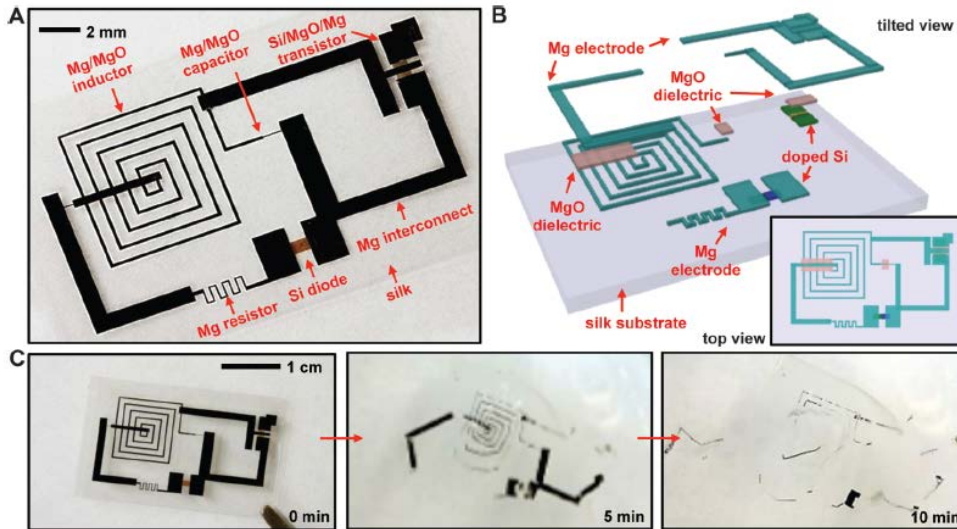


Nanopatterns



Examples of semiconductor devices/structures

Thin film devices



Course Schedule

| Weekly Course Schedule | | |
|------------------------|--|------------|
| Week | Description | *Remarks |
| 1st | Introduction and safety training | Experiment |
| 2nd | Growth and characterization of compound semiconductors | Experiment |
| 3rd | Optical lithography | Experiment |
| 4th | Metallization | Experiment |
| 5th | Lift-off | Experiment |
| 6th | Ohmic contacts of semiconductor devices | Experiment |
| 7th | Sputtering of dielectric films | Experiment |
| 8th | Mid-term exam | Experiment |
| 9th | Thickness measurement of dielectric thin film | Experiment |
| 10th | Wet etching of compound semiconductors | Experiment |
| 11th | PECVD of SiO ₂ and SiN _x film | Experiment |
| 12th | Dry etching of dielectric films | Experiment |
| 13th | Dry etching of compound semiconductors | Experiment |
| 14th | Scanning electron microscopy | Experiment |
| 15th | Measurement of Schottky diode characteristics | Experiment |
| 16th | Final Exam | |

'Real' Schedule

Weekly Course Schedule

| Calendar | Description | *Remarks |
|-----------|--|---------------|
| 1st week | Introduction/Semiconductor Process Overview | Lectures |
| 2nd week | Semiconductor Process Overview | Lectures |
| 3rd week | Growth of compound semiconductors – MBE & MOCVD | Presentations |
| 4th week | Photolithography / Nanolithography | Presentations |
| 5th week | PECVD / Oxidation | Presentations |
| 6th week | Dry etching / Cleaning & Wet etching | Presentations |
| 7th week | Diffusion / Ion implantation | Presentations |
| 8th week | Mid-term Week | No midterm |
| 9th week | Metallization (Ohmic Contacts) / TLM measurement | Presentations |
| 10th week | Fabrication & Measurement of TLM patterns | Experiments |
| 11th week | | Experiments |
| 12th week | | Experiments |
| 13th week | | Experiments |
| 14th week | | Experiments |
| 15th week | | Experiments |
| 16th week | Final Exam & Final Report | |

Assessment and grading

Attendance (5%)

Presentations and pre-reports (30%)

→ 15 min **presentation**

→ **Pre-report** for 6 presentation topics (select one topic per week, ~3 pages)

Final report (30%)

Final Exam (35%)

Presentation Subjects

- 1. Crystal Growth (MBE, MOCVD)**
- 2. Oxidation**
- 3. Photolithography**
- 4. Etching**
- 5. Diffusion**
- 6. Film deposition**
- 7. Metallization**
- 8. Transmission Line Measurement (TLM)**

Question or Comment?